

IN THE UNITED STATES PATENT & TRADEMARK OFFICE

In re Application of:

Lu et al.

Serial No.: 10/534,415

Art Unit: Unassigned

Filed: May 6, 2005

Examiner: Unassigned

For: A Method For Generating  
A Quality Oriented  
Significance Map For  
Assessing The Quality Of An  
Image Or Video

TRANSMITTAL OF SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313

Sir:

Enclosed please find Applicants' Supplemental Information  
Disclosure Statement.

Date: November 8, 2005

By:

  
Niky Economy Syrengelas, Esq.

Reg. No. 46680

Certificate of Mailing (37 CFR 1.10)

I hereby certify that this response (along with any paper referred to as being attached or enclosed) is being deposited in Express Mail using Express Mail Post Office to Addressee with the United States Postal Service on the date shown below in an envelop addressed to Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313.

Express Mail No. EV656494144US  
Date: November 8, 2005

  
Michelle Campero

ATTY DOCKET NO.  
**212/746US**SERIAL NO.  
**10/534,415**

## LIST OF PRIOR ART CITED BY APPLICANT

(use several sheets if necessary)

APPLICANT  
**Lu et al.**FILING DATE  
**May 6, 2005**GROUP  
**Unassigned**

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL						
	AM						

## OTHER PRIOR ART (including Author, Title, Date, Pertinent Pages, Etc.)

		Stefen Winkler, "Vision Models and Quality Metrics for Image Processing Applications", Ph.D. Thesis #2313, Swiss Federal Institute of Technology, Lusanne, Switzerland, 2000
		S. Yao, et al, "Video Quality Assessment Using Neural Network Based on Multi-Feature Extraction", submitted to IEE Electrical Letters
		S. Yao, et al, "Perceptual Visual Quality Evaluation with Multi-Feature" Laboratories for Information Technology

EXAMINER	DATE CONSIDERED

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant